TOSHIBA Field Effect Transistor Silicon N Channel MOS Type

# SSM6N09FU

High Speed Switching Applications

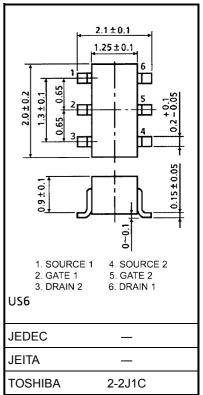
- Small package
- Low Drain-Source ON resistance.
  - $R_{on} = 0.7 \Omega (max) (@V_{GS} = 10 V)$
  - : Ron = 1.2  $\Omega$  (max) (@V\_{\rm GS} = 4 V)

Note1: Total rating, mounted on FR4 board

#### Maximum Ratings (Ta = 25°C) (Q1, Q2 Common)

Characteristics		Symbol	Rating	Unit	
Drain-Source voltage		V <sub>DS</sub>	30	V	
Gate-Source voltage		V <sub>GSS</sub>	±20	V	
Drain current	DC	۱ <sub>D</sub>	400	mA	
	Pulse	I <sub>DP</sub>	800		
Drain power dissipation (Ta = $25^{\circ}$ C)		P <sub>D</sub> (Note1)	300	mW	
Channel temperature		T <sub>ch</sub>	150	°C	
Storage temperature range		T <sub>stg</sub>	-55~150	°C	

(25.4 mm  $\times$  25.4 mm  $\times$  1.6 t, Cu Pad: 0.32 mm  $^2 \times$  6) Figure 1.



Weight: 6.8 mg (typ.)

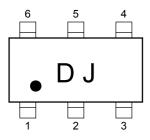
#### **Handling Precaution**

When handling individual devices (which are not yet mounting on a circuit board), be sure that the environment is protected against electrostatic electricity. Operators should wear anti-static clothing, and containers and other objects that come into direct contact with devices should be made of anti-static materials.



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#### Marking



Equivalent Circuit (top view)

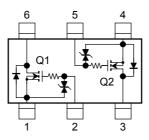


Figure 1: 25.4 mm × 25.4 mm × 1.6 t,

Cu Pad:  $0.32 \text{ mm}^2 \times 6$ 

#### Electrical Characteristics (Ta = 25°C) (Q1, Q2 common)

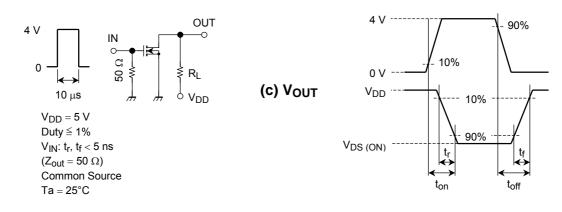
Characteristics		Symbol	Test Condition	Min	Тур.	Max	Unit	
Gate leakage current		I <sub>GSS</sub>	$V_{GS}=\pm 16~V,~V_{DS}=0$			±1	μA	
Drain-Source breakdown voltage		V (BR) DSS	$I_D = 1 \text{ mA}, V_{GS} = 0$	30		_	V	
Drain cut-off current		I <sub>DSS</sub>	$V_{DS} = 30 \text{ V}, \text{ V}_{GS} = 0$			1	μA	
Gate threshold voltage		V <sub>th</sub>	$V_{DS} = 5 \text{ V}, \text{ I}_{D} = 0.1 \text{ mA}$	1.1		1.8	V	
Forward transfer admittance		Y <sub>fs</sub>	$V_{DS} = 5 \text{ V}, \text{ I}_{D} = 200 \text{ mA} \qquad (\text{Note2})$	270		_	mS	
Drain-Source ON resistance		R <sub>DS (ON)</sub>	$I_D = 200 \text{ mA}, V_{GS} = 10 \text{ V}$ (Note2)		0.53	0.7	Ω	
			$I_D = 200 \text{ mA}, V_{GS} = 4 \text{ V} \qquad (\text{Note2})$		0.8	1.2		
			$I_D = 200 \text{ mA}, V_{GS} = 3.3 \text{ V}$ (Note2)	_	1.0	1.7		
Input capacitance		C <sub>iss</sub>	$V_{DS} = 5 V, V_{GS} = 0, f = 1 MHz$	_	20		pF	
Reverse transfer capacitance		C <sub>rss</sub>	$V_{DS} = 5 V, V_{GS} = 0, f = 1 MHz$	_	7		pF	
Output capacitance		C <sub>oss</sub>	$V_{DS} = 5 V, V_{GS} = 0, f = 1 MHz$		16		pF	
Switching time	Turn-on time	t <sub>on</sub>	$V_{DD} = 5 \text{ V}, \text{ I}_{D} = 200 \text{ mA},$		72			
	Turn-off time	t <sub>off</sub>	V <sub>GS</sub> = 0~4 V	_	68		ns	

Note2: Pulse test

#### Switching Time Test Circuit (Q1, Q2 Common)

(a) Test circuit

(b) V<sub>IN</sub>

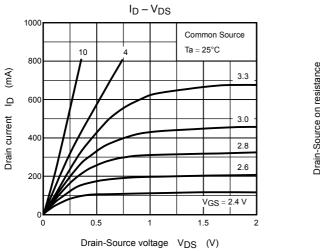


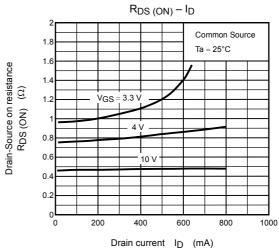
#### Precaution

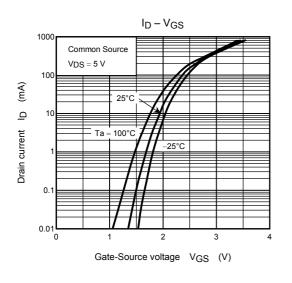
 $V_{th}$  can be expressed as voltage between gate and source when low operating current value is  $I_D = 100 \ \mu A$  for this product. For normal switching operation,  $V_{GS}$  (on) requires higher voltage than  $V_{th}$  and  $V_{GS}$  (off) requires lower voltage than  $V_{th}$ . (Relationship can be established as follows:  $V_{GS}$  (off)  $< V_{th} < V_{GS}$  (on) )

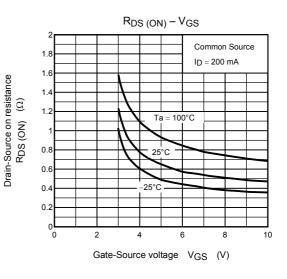
Please take this into consideration for using the device. VGS recommended voltage of 4 V or higher to turn on this product.

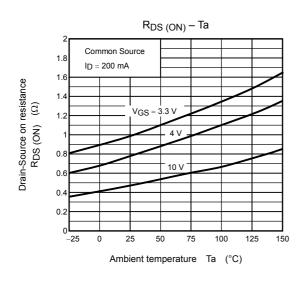
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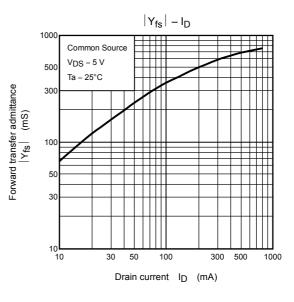




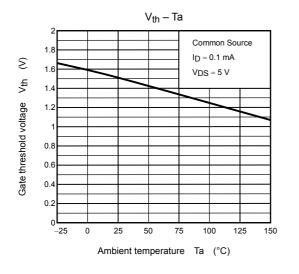


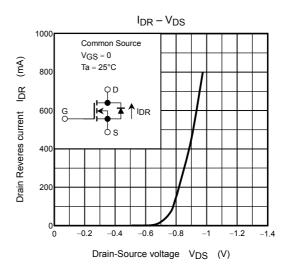


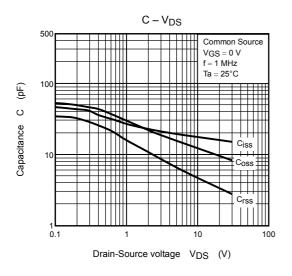


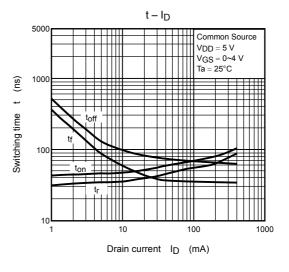


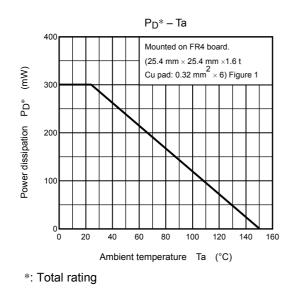
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